

Search Notes

Application/Control No.

10/081,863

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
705	12	11/20/2005	ECT
726	26	11/20/2005	ECT
713	156	11/20/2005	ECT
380	28		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES, INVENTOR	11/20/2005	ECT
STIC SEARCH EIC 2100	11/20/2005	ECT